

Application/Control No.	Applicant(s)/Patent under Reexamination
10/041,875	MAUTINO ET AL.
Examiner	Art Unit
Frantz F. Jules	3617

	SEARCHED						
Class	Subclass	Date	Examiner				
213	155						
-	1511						
	10/	2/13/05	FRI				
	113	/ /					
	114						
		-					
		_					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u>.</u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Scarched Bast DataBases &	_	_		
DATABASES &	-			
Shocs. See		,		
Shocs. See' Attachment	, ,			
Inside.	7/13/01	PO		
	,			
· ·				
		:		
·				